

# **MOSFET**

Metal Oxide Semiconductor Field Effect Transistor

# CoolMOS™ C7

650V CoolMOS™ C7 Power Transistor IPB65R065C7

# **Data Sheet**

Rev. 2.0 Final

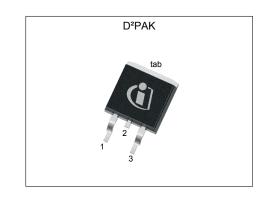


### IPB65R065C7

# 1 Description

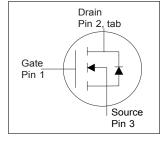
CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies.

CoolMOS™ C7 series combines the experience of the leading SJ MOSFET supplier with high class innovation. The product portfolio provides all benefits of fast switching superjunction MOSFETs offering better efficiency, reduced gate charge, easy implementation and outstanding reliability.



#### **Features**

- Increased MOSFET dv/dt ruggedness
- Better efficiency due to best in class FOM R<sub>DS(on)</sub>\*E<sub>oss</sub> and R<sub>DS(on)</sub>\*Q<sub>g</sub>
- Best in class R<sub>DS(on)</sub> /package
- Easy to use/drive
- Pb-free plating, halogen free mold compound
- Qualified for industrial grade applications according to JEDEC (J-STD20 and JESD22)



### **Benefits**

- Enabling higher system efficiency
- Enabling higher frequency / increased power density solutions
- System cost / size savings due to reduced cooling requirements
- Higher system reliability due to lower operating temperatures





### **Applications**

PFC stages and hard switching PWM stages for e.g. Computing, Server, Telecom, UPS and Solar.

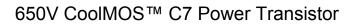
Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.



Table 1 Key Performance Parameters

Table 1 Rey 1 chlorinance 1 draineters						
Parameter	Value	Unit				
V <sub>DS</sub> @ T <sub>j,max</sub>	700	V				
$R_{DS(on),max}$	65	mΩ				
$Q_{g.typ}$	64	nC				
$I_{D,pulse}$	145	A				
E <sub>oss</sub> @400V	8	μJ				
Body diode di/dt	60	A/µs				

Type / Ordering Code	Package	Marking	Related Links
IPB65R065C7	PG-TO 263	65C7065	see Appendix A





# IPB65R065C7

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Description
Maximum ratings
Thermal characteristics
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**2** Maximum ratings at  $T_j = 25$ °C, unless otherwise specified

Table 2 **Maximum ratings** 

Daniel de la constant	0	Values				
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current 1)	I <sub>D</sub>	-	-	33 21	А	T <sub>C</sub> =25°C T <sub>C</sub> =100°C
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	-	-	145	Α	T <sub>C</sub> =25°C
Avalanche energy, single pulse	<b>E</b> <sub>AS</sub>	-	-	171	mJ	I <sub>D</sub> =10.2A; V <sub>DD</sub> =50V; see table 10
Avalanche energy, repetitive	<b>E</b> AR	-	-	0.85	mJ	I <sub>D</sub> =10.2A; V <sub>DD</sub> =50V; see table 10
Avalanche current, single pulse	I <sub>AS</sub>	-	-	10.2	Α	-
MOSFET dv/dt ruggedness	dv/dt	-	-	100	V/ns	V <sub>DS</sub> =0400V
Gate source voltage (static)	V <sub>GS</sub>	-20	-	20	V	static;
Gate source voltage (dynamic)	V <sub>GS</sub>	-30	-	30	V	AC (f>1 Hz)
Power dissipation	P <sub>tot</sub>	-	-	171	W	<i>T</i> <sub>C</sub> =25°C
Storage temperature	T <sub>stg</sub>	-55	-	150	°C	-
Operating junction temperature	T <sub>j</sub>	-55	-	150	°C	-
Mounting torque	-	-	-	n.a.	Ncm	-
Continuous diode forward current	I <sub>S</sub>	-	-	33	Α	<i>T</i> <sub>C</sub> =25°C
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	-	-	145	Α	T <sub>C</sub> =25°C
Reverse diode dv/dt <sup>3)</sup>	dv/dt	-	-	1.5	V/ns	$V_{DS}$ =0400V, $I_{SD}$ <= $I_{S}$ , $T_{j}$ =25°C see table 8
Maximum diode commutation speed	di₁/dt	-	-	60	A/μs	$V_{DS}$ =0400V, $I_{SD}$ <= $I_{S}$ , $T_{j}$ =25°C see table 8
Insulation withstand voltage	V <sub>ISO</sub>	-	-	n.a.	V	V <sub>rms</sub> , T <sub>C</sub> =25°C, t=1min

 $<sup>^{1)}</sup>$  Limited by  $T_{j\,max}.$   $^{2)}$  Pulse width  $t_p$  limited by  $T_{j,max}$   $^{3)}$  Identical low side and high side switch with identical  $\textit{R}_{\textrm{G}}$ 



## 3 Thermal characteristics

### Table 3 Thermal characteristics

Paramatan	Oh a l	Values			11!4	Nata / Tank Oan little
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	0.73	°C/W	-
Thermal resistance, junction - ambient	R <sub>thJA</sub>	-	-	62	°C/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version	$R_{ m thJA}$	-	35	45	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area for drain connection and cooling. PCB is vertical without air stream cooling.
Soldering temperature, wave- & reflow soldering allowed	T <sub>sold</sub>	-	-	260	°C	reflow MSL1



# **4 Electrical characteristics** at $T_j$ =25°C, unless otherwise specified

Table 4 **Static characteristics** 

	Ola a l		Values			
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	650	-	-	V	$V_{GS}$ =0V, $I_{D}$ =1mA
Gate threshold voltage	V <sub>(GS)th</sub>	3	3.5	4	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=0.85{\rm mA}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	- 15	1 -	μΑ	V <sub>DS</sub> =650, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C V <sub>DS</sub> =650, V <sub>GS</sub> =0V, T <sub>j</sub> =150°C
Gate-source leakage current	I <sub>GSS</sub>	-	-	100	nA	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.058 0.138	0.065	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =17.1A, T <sub>j</sub> =25°C V <sub>GS</sub> =10V, I <sub>D</sub> =17.1A, T <sub>j</sub> =150°C
Gate resistance	R <sub>G</sub>	-	0.85	-	Ω	f=1MHz, open drain

Table 5 **Dynamic characteristics** 

Davamatav	Cymphal	Values			11	Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance	Ciss	-	3020	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =400V, f=250kHz	
Output capacitance	Coss	-	48	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =400V, f=250kHz	
Effective output capacitance, energy related 1)	C <sub>o(er)</sub>	-	100	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =0400V	
Effective output capacitance, time related	C <sub>o(tr)</sub>	-	1110	-	pF	$I_D$ =constant, $V_{GS}$ =0V, $V_{DS}$ =0400V	
Turn-on delay time	t <sub>d(on)</sub>	-	17	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9	
Rise time	t <sub>r</sub>	-	14	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9	
Turn-off delay time	$t_{ m d(off)}$	-	72	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9	
Fall time	t <sub>f</sub>	-	7	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13 V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9	

Table 6 Gate charge characteristics

Parameter	Sumb al		Values			Nata / Tank Oam did an
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	$Q_{ m gs}$	-	16	-	nC	$V_{\rm DD}$ =400V, $I_{\rm D}$ =17.1A, $V_{\rm GS}$ =0 to 10V
Gate to drain charge	$Q_{ m gd}$	-	21	-	nC	$V_{\rm DD}$ =400V, $I_{\rm D}$ =17.1A, $V_{\rm GS}$ =0 to 10V
Gate charge total	Qg	-	64	-	nC	$V_{\rm DD}$ =400V, $I_{\rm D}$ =17.1A, $V_{\rm GS}$ =0 to 10V
Gate plateau voltage	$V_{ m plateau}$	-	5.4	-	V	$V_{\rm DD}$ =400V, $I_{\rm D}$ =17.1A, $V_{\rm GS}$ =0 to 10V

 $<sup>^{1)}</sup>$   $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V  $^{2)}$   $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V



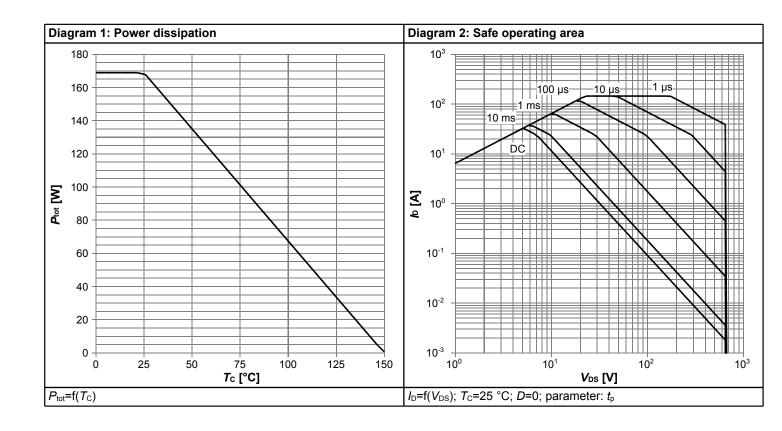
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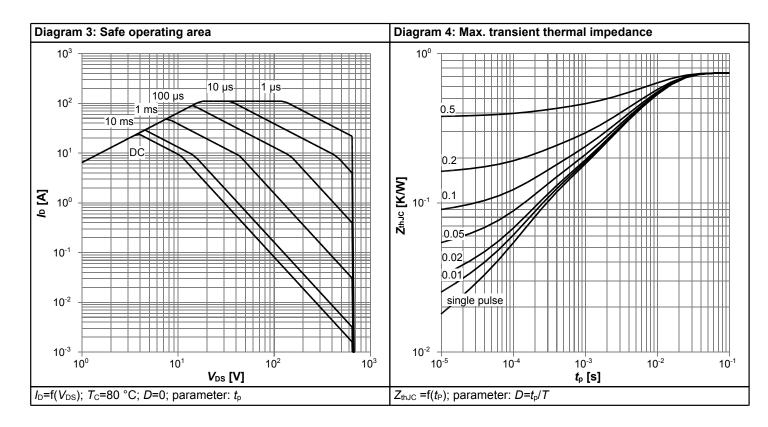
# Table 7 Reverse diode characteristics

Davameter	Symbol	Values			Unit	Note / Test Condition
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Diode forward voltage	<b>V</b> <sub>SD</sub>	-	0.9	-	V	$V_{GS}$ =0V, $I_F$ =17.1A, $T_j$ =25°C
Reverse recovery time	t <sub>rr</sub>	-	800	-	ns	$V_R$ =400V, $I_F$ =33A, $di_F/dt$ =60A/ $\mu$ s; see table 8
Reverse recovery charge	Qrr	-	10	-	μC	$V_R$ =400V, $I_F$ =33A, $di_F/dt$ =60A/ $\mu$ s; see table 8
Peak reverse recovery current	I <sub>rrm</sub>	-	30	-	А	$V_R$ =400V, $I_F$ =33A, $di_F/dt$ =60A/ $\mu$ s; see table 8

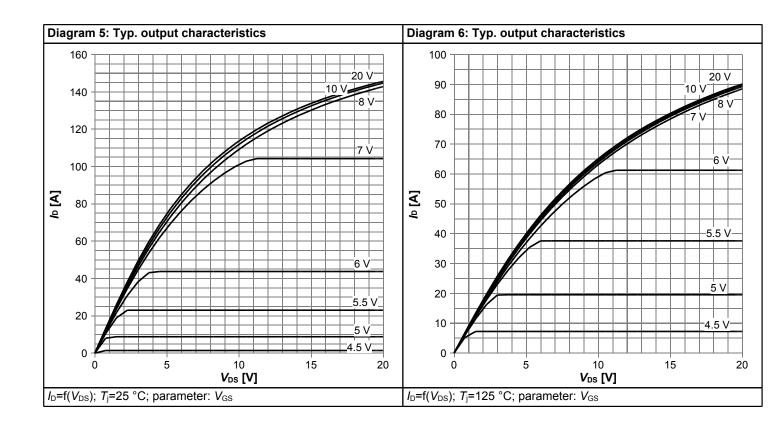


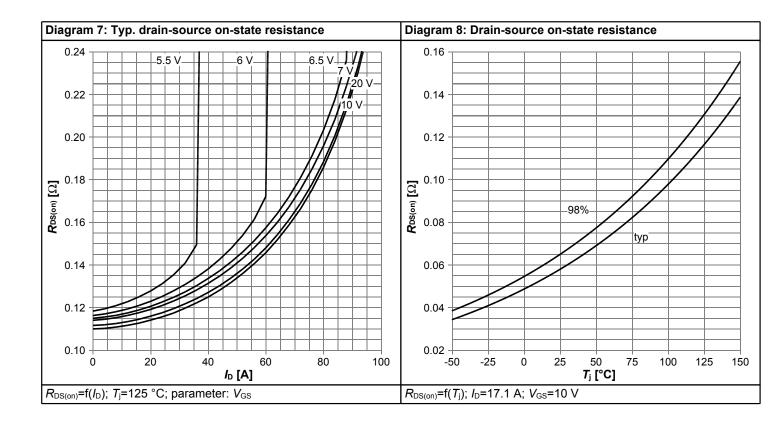
# 5 Electrical characteristics diagrams



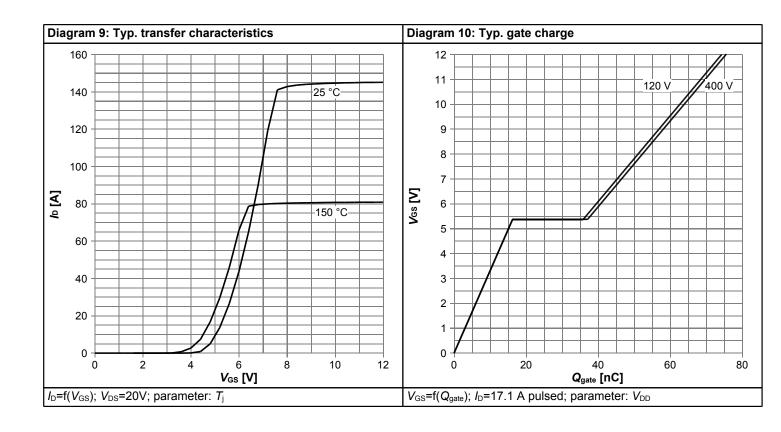


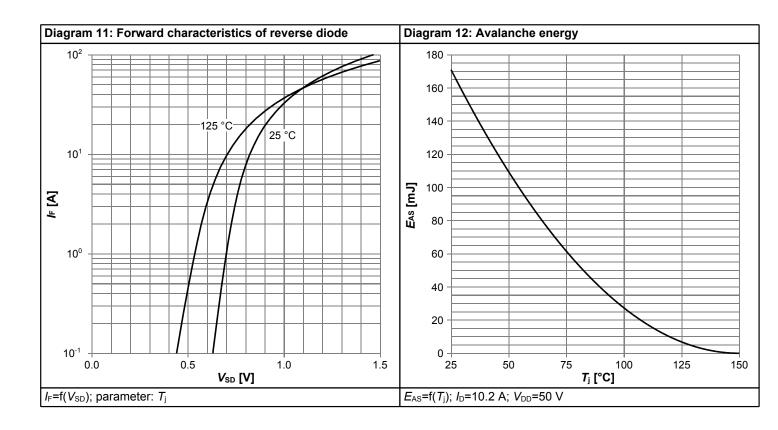




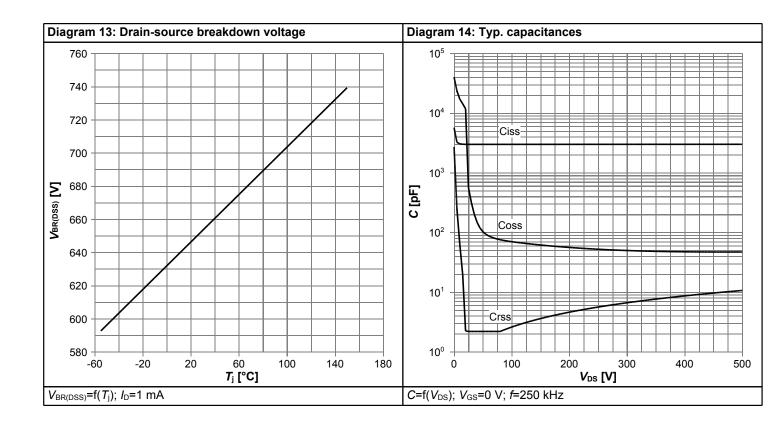


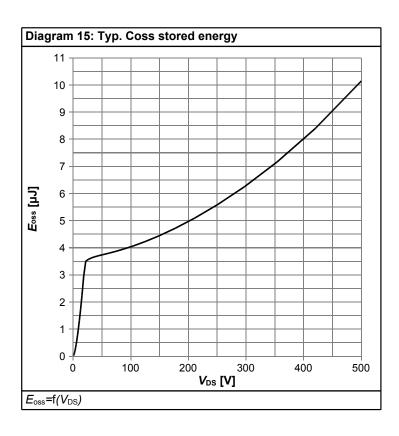














### 6 Test Circuits

Table 8 Diode characteristics

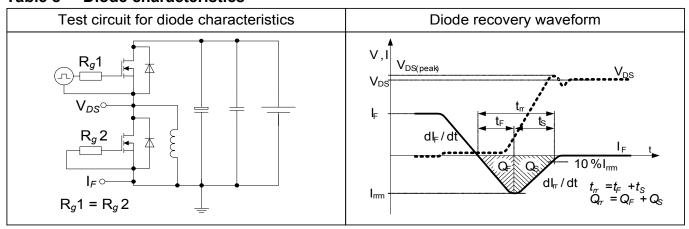


Table 9 Switching times

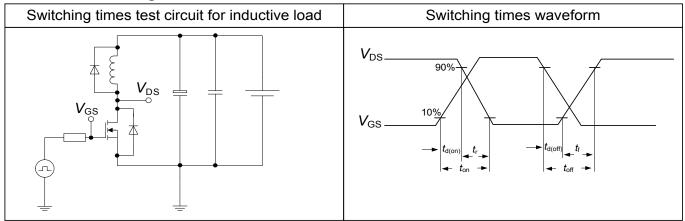
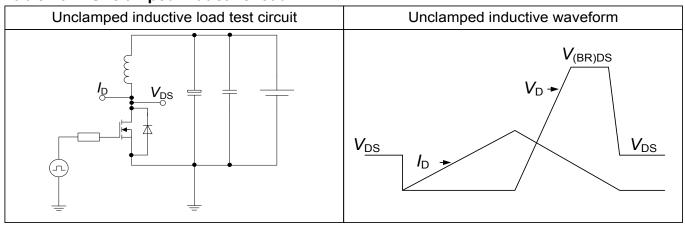


Table 10 Unclamped inductive load





# 7 Package Outlines

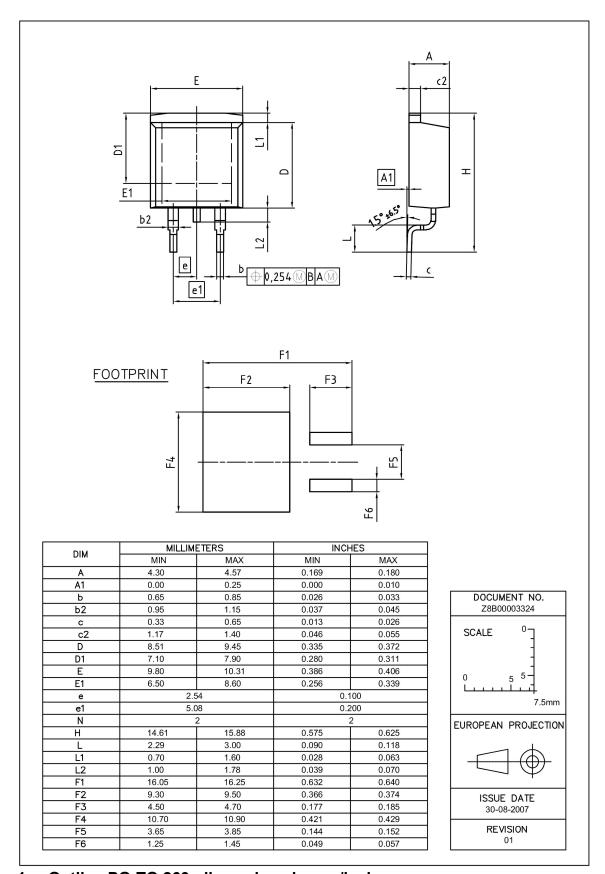


Figure 1 Outline PG-TO 263, dimensions in mm/inches



# 8 Appendix A

### Table 11 Related Links

- IFX CoolMOS<sup>™</sup> C7 Webpage: <u>www.infineon.com</u>
- IFX CoolMOS<sup>™</sup> C7 application note: <u>www.infineon.com</u>
- IFX CoolMOS<sup>™</sup> C7 simulation model: www.infineon.com
- IFX Design tools: www.infineon.com



### 650V CoolMOS™ C7 Power Transistor

IPB65R065C7

### **Revision History**

IPB65R065C7

Revision: 2013-10-11, Rev. 2.0

Previous Revision

1 TOVIOGO T COVIDION					
Revision	Date	Subjects (major changes since last revision)			
2.0	2013-10-11	Release of final version			

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